

Application/Control No.	Applicant(s)/Patent under Reexamination
10/721,196	MARTIN ET AL.
Examiner	Art Unit
Michael D. Helman	2424

SEARCHED			
Class	Subclass	Date	Examiner
	Subclass	Date	Lammer
706	48	7/13/2006	мвн
707	6	7/13/2006	MBH
706	206	7/13/2006	мвн
707	6	7/27/2006	МВН
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
706/48 (text search only see search history printout)	7/27/2006	МВН
707/6 (text search only see search history printout)	7/13/2006	МВН
709/206 (text search only see search history printout)	7/13/2006	МВН
Kenneth Coulter, Primary Examiner Art Unit 2141	7/13/2006	МВН
Luke Wassum, Primary Examiner Art Unit, 2167	7/13/2006	МВН
Jim Hirl, Primary Examiner Art Unit, 2121	7/13/2006	МВН
101 Help Panel Tod Swann, (TQAS) Will Grant, (TQAS)	7/27/2006	МВН
Jason Cardone, SPE Art Unit 2145	7/27/2006	мвн



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10/721,	196	MARTIN ET AL	•	
Examine	er	Art Unit		
Michael	B. Holmes	2121		

SEARCHED			
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NO (INCLUDING SEARCI		)
	DATE	EXMR
707/6 (text search only see search history printout)	7/27/2006	МВН
Leslie Wong, Primary Examiner Art Unit 2164	7/27/2006	мвн
David Eng, Primary Examiner Art Unit 2155		
Le Luu, Primary Examiner Art Unit 2141 emailed questions	7/27/2006	МВН
IEEE	7/27/2006	МВН
Inventor name search	7/27/2006	МВН
WEST	7/27/2006	МВН